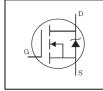


AUTOMOTIVE GRADE

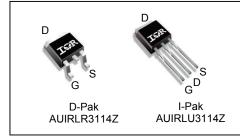
HEXFET® Power MOSFET

Features

- Advanced Process Technology
- Ultra Low On-Resistance
- · Logic Level Gate Drive
- 175°C Operating Temperature
- Fast Switching
- Repetitive Avalanche Allowed up to Timax
- · Lead-Free, RoHS Compliant
- Automotive Qualified *



V _{DSS}		40V
$R_{DS(on)}$	typ.	4.9m $Ω$
	max.	6.5mΩ
D (Silicon Limited)		130A®
I _{D (Package L}	imited)	42A



G	D	S
Gate	Drain	Source

Description

Specifically designed for Automotive applications, this HEXFET® Power MOSFET utilizes the latest processing techniques to achieve extremely low on-resistance per silicon area. Additional features of this design are a 175°C junction operating temperature, fast switching speed and improved repetitive avalanche rating. These features combine to make this design an extremely efficient and reliable device for use in Automotive applications and a wide variety of other applications.

Book port number	Backage Type Standard Pack		Orderable Part Number	
Base part number	Package Type	Form	Quantity	Orderable Part Number
AUIRLU3114Z	I-Pak	Tube	75	AUIRLU3114Z
AUIRL R31147	D. Dok	Tube	75	AUIRLR3114Z
AUIRLR3114Z	D-Pak	Tape and Reel Left	3000	AUIRLR3114ZTRL

Absolute Maximum Ratings

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only; and functional operation of the device at these or any other condition beyond those indicated in the specifications is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability. The thermal resistance and power dissipation ratings are measured under board mounted and still air conditions. Ambient temperature (TA) is 25°C, unless otherwise specified.

Symbol	Parameter	Max.	Units
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	1309	
I _D @ T _C = 100°C	Continuous Drain Current, V _{GS} @ 10V (Silicon Limited)	899	1 ,
I _D @ T _C = 25°C	Continuous Drain Current, V _{GS} @ 10V (Package Limited)	42	A
I _{DM}	Pulsed Drain Current ①	500]
P _D @T _C = 25°C	Maximum Power Dissipation	140	W
	Linear Derating Factor	0.95	W/°C
V_{GS}	Gate-to-Source Voltage	± 16	V
E _{AS}	Single Pulse Avalanche Energy (Thermally Limited) ②	130	m l
E _{AS} (Tested)	Single Pulse Avalanche Energy Tested Value ®	260	- mJ
I _{AR}	Avalanche Current ①	See Fig.15,16, 12a, 12b	Α
E _{AR}	Repetitive Avalanche Energy ©		mJ
T_J	Operating Junction and	-55 to + 175	
T_{STG}	Storage Temperature Range		°C
	Soldering Temperature, for 10 seconds (1.6mm from case)	300	

Thermal Resistance

THEITHAI INCOIDEAN	<u> </u>			
Symbol	Parameter	Тур.	Max.	Units
$R_{\theta JC}$	Junction-to-Case		1.05	
$R_{\theta JA}$	Junction-to-Ambient (PCB Mount) ⑦		50	°C/W
$R_{\theta JA}$	Junction-to-Ambient		110	

HEXFET® is a registered trademark of Infineon.

^{*}Qualification standards can be found at www.infineon.com



Static @ T_J = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	40			V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_{J}$	Breakdown Voltage Temp. Coefficient		0.032		V/°C	Reference to 25°C, I _D = 1mA
D	Static Drain to Source On Desistance		3.9	4.9	0	V _{GS} = 10V, I _D = 42A ③
$R_{DS(on)}$	Static Drain-to-Source On-Resistance		5.2	6.5	mΩ	V _{GS} = 4.5V, I _D = 42A ③
$V_{GS(th)}$	Gate Threshold Voltage	1.0		2.5	V	$V_{DS} = V_{GS}, I_{D} = 100 \mu A$
gfs	Forward Trans conductance	98			S	$V_{DS} = 10V, I_{D} = 42A$
ı	Drain to Source Leakage Current			20	μA	$V_{DS} = 40 \text{ V}, V_{GS} = 0 \text{V}$
DSS	Drain-to-Source Leakage Current			250	μΑ	$V_{DS} = 40V, V_{GS} = 0V, T_{J} = 125^{\circ}C$
1	Gate-to-Source Forward Leakage			100	n ^	V _{GS} = 16V
GSS	Gate-to-Source Reverse Leakage			-100	nA	V _{GS} = -16V

Dynamic Electrical Characteristics @ T_J = 25°C (unless otherwise specified)

Q_g	Total Gate Charge	 40	56		I _D = 42A
Q_{gs}	Gate-to-Source Charge	 12		nC	$V_{DS} = 20V$
Q_{gd}	Gate-to-Drain Charge	 18			V _{GS} = 4.5V3
$t_{d(on)}$	Turn-On Delay Time	 25			$V_{DD} = 20V$
t _r	Rise Time	 140			$I_D = 42A$
$t_{d(off)}$	Turn-Off Delay Time	 33		ns	$R_G = 3.7\Omega$
t _f	Fall Time	 50			V _{GS} = 4.5V3
L _D	Internal Drain Inductance	 4.5			Between lead, 6mm (0.25in.)
Ls	Internal Source Inductance	 7.5			from package and center of die contact
C _{iss}	Input Capacitance	 3810			$V_{GS} = 0V$
Coss	Output Capacitance	 650			$V_{DS} = 25V$
C_{rss}	Reverse Transfer Capacitance	 350			f = 1.0MHz
C _{oss}	Output Capacitance	 2390		pF	$V_{GS} = 0V, V_{DS} = 1.0V f = 1.0MHz$
C_{oss}	Output Capacitance	 580			$V_{GS} = 0V$, $V_{DS} = 32V$ $f = 1.0MHz$
Coss eff.	Effective Output Capacitance	 820			$V_{GS} = 0V, V_{DS} = 0V \text{ to } 32V $

Diode Characteristics

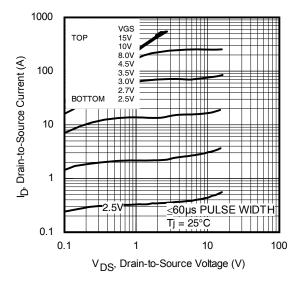
	Parameter	Min.	Тур.	Max.	Units	Conditions
I_	Continuous Source Current			429		MOSFET symbol
I _S	(Body Diode)			429	_	showing the
	Pulsed Source Current			500	Α	integral reverse
I _{SM}	(Body Diode) ①			300		p-n junction diode.
V_{SD}	Diode Forward Voltage			1.3	V	$T_J = 25^{\circ}C, I_S = 42A, V_{GS} = 0V$ ③
t _{rr}	Reverse Recovery Time		30	45	ns	$T_J = 25^{\circ}C$, $I_F = 42A$, $V_{DD} = 20V$
Q_{rr}	Reverse Recovery Charge		27	41	nC	di/dt = 100A/µs③
t _{on}	Forward Turn-On Time	Intrinsio	turn-or	time is	negligil	ole (turn-on is dominated by L _S +L _D)

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)
- ② Limited by T_{Jmax} , starting $T_J = 25$ °C, L = 0.15mH, $R_G = 25\Omega$, $I_{AS} = 42$ A, $V_{GS} = 10$ V. Part not recommended for use above this value.
- \oplus C_{oss} eff. is a fixed capacitance that gives the same charging time as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS}
- © Limited by T_{Jmax}, see Fig.12a, 12b, 15, 16 for typical repetitive avalanche performance.
- This value determined from sample failure population. 100% tested to this value in production.
- When mounted on 1" square PCB (FR-4 or G-10 Material). For recommended footprint and soldering techniques refer to application note #AN-994.
- ® R_θ is measured at T_J approximately 90°C
- © Calculated continuous current based on maximum allowable junction temperature. Bond wire current limit is 42A. Note that current limitations arising from heating of the device leads may occur with some lead mounting arrangements.

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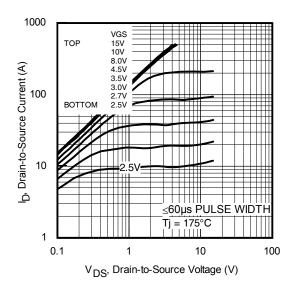
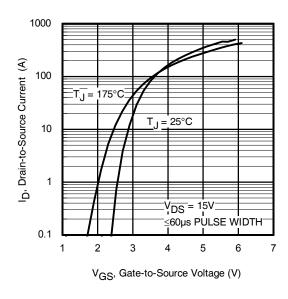


Fig. 1 Typical Output Characteristics

Fig. 2 Typical Output Characteristics





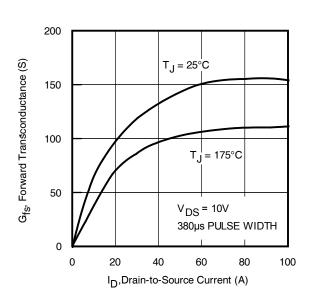


Fig. 4 Typical Forward Trans conductance Vs. Drain Current



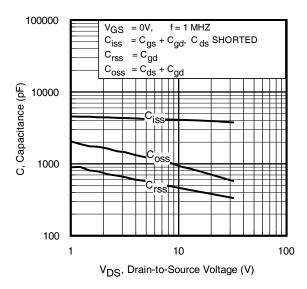


Fig 5. Typical Capacitance vs. Drain-to-Source Voltage

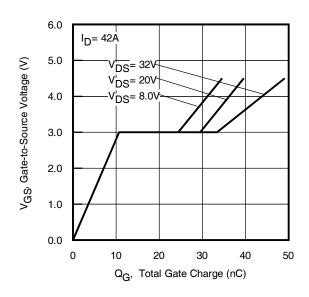


Fig 6. Typical Gate Charge vs. Gate-to-Source Voltage

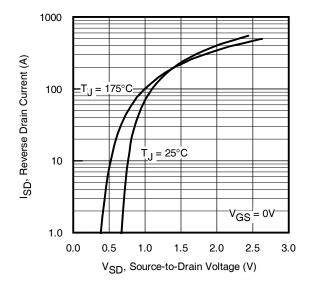


Fig. 7 Typical Source-to-Drain Diode Forward Voltage

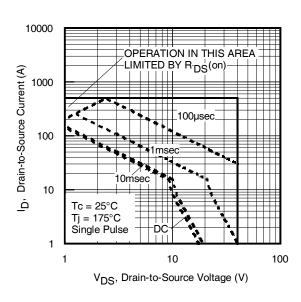
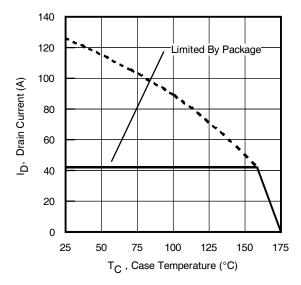


Fig 8. Maximum Safe Operating Area

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4





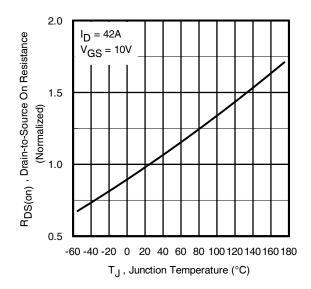


Fig 9. Maximum Drain Current Vs. Case Temperature

Fig 10. Normalized On-Resistance Vs. Temperature

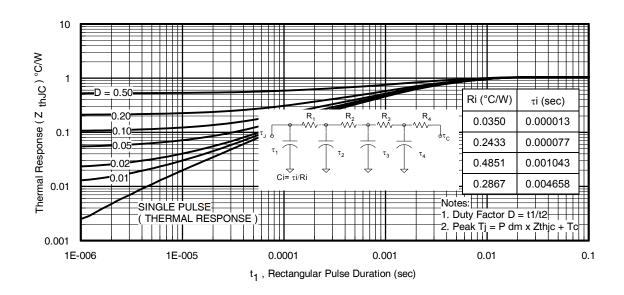


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case



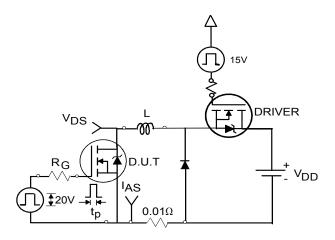


Fig 12a. Unclamped Inductive Test Circuit

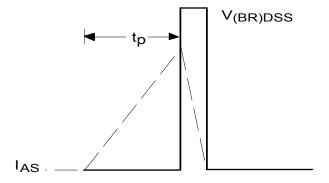


Fig 12b. Unclamped Inductive Waveforms

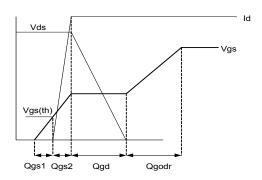


Fig 13a. Gate Charge Waveform

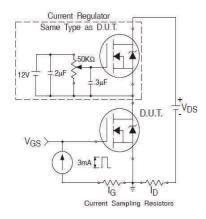


Fig 13b. Gate Charge Test Circuit

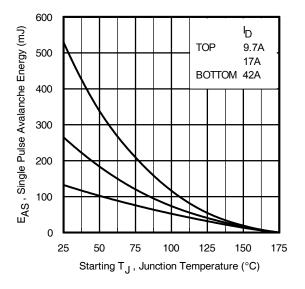


Fig 12c. Maximum Avalanche Energy vs. Drain Current

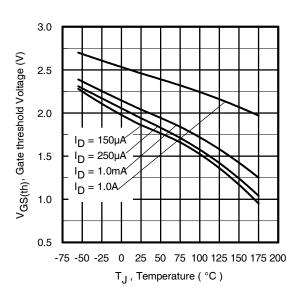


Fig 14. Threshold Voltage Vs. Temperature

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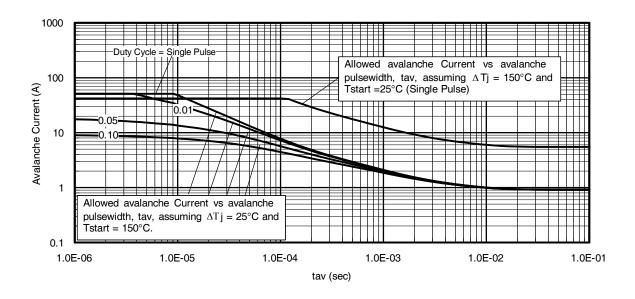


Fig 15. Typical Avalanche Current Vs. Pulse width

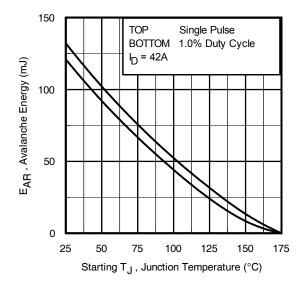


Fig 16. Maximum Avalanche Energy Vs. Temperature

Notes on Repetitive Avalanche Curves , Figures 15, 16:

(For further info, see AN-1005 at www.infineon.com)

- Avalanche failures assumption:
 Purely a thermal phenomenon and failure occurs at a temperature far in excess of T_{imax}. This is validated for every part type.
- 2. Safe operation in Avalanche is allowed as long as T_{jmax} is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 12a, 12b.
- 4. PD (ave) = Average power dissipation per single avalanche pulse.
- 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. lav = Allowable avalanche current.
- 7. ΔT = Allowable rise in junction temperature, not to exceed T_{jmax} (assumed as 25°C in Figure 15, 16).

tav = Average time in avalanche.

D = Duty cycle in avalanche = tav ·f

ZthJC(D, tav) = Transient thermal resistance, see Figures 13)

$$\begin{split} P_{D \; (ave)} &= 1/2 \; (\; 1.3 \cdot BV \cdot I_{av}) = \Delta T / \; Z_{thJC} \\ I_{av} &= 2\Delta T / \; [1.3 \cdot BV \cdot Z_{th}] \\ E_{AS \; (AR)} &= P_{D \; (ave)} \cdot t_{av} \end{split}$$



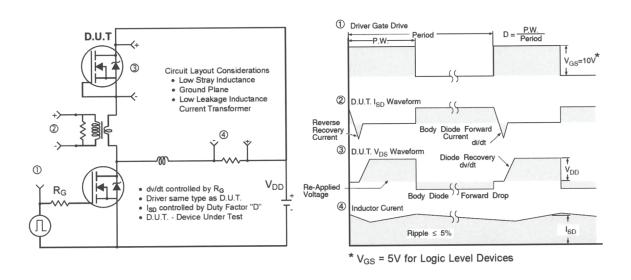


Fig 17. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

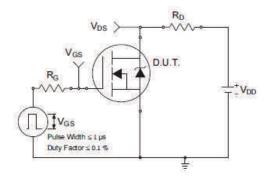


Fig 18a. Switching Time Test Circuit

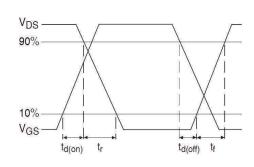
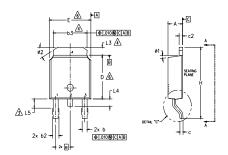


Fig 18b. Switching Time Waveforms

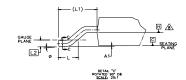
2015-10-29

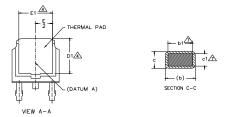


D-Pak (TO-252AA) Package Outline (Dimensions are shown in millimeters (inches))









NOTES:

- 1.- DIMENSIONING AND TOLERANCING PER ASME Y14.5M-1994
- 2.- DIMENSION ARE SHOWN IN INCHES [MILLIMETERS].
- LEAD DIMENSION UNCONTROLLED IN L5.
- A- DIMENSION D1, E1, L3 & b3 ESTABLISH A MINIMUM MOUNTING SURFACE FOR THERMAL PAD.
- 5.— SECTION C-C DIMENSIONS APPLY TO THE FLAT SECTION OF THE LEAD BETWEEN .005 AND 0.10 [0.13 AND 0.25] FROM THE LEAD TIP.
- Limited Dimension D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005 [0.13] PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTMOST EXTREMES OF THE PLASTIC BODY.
- A- DIMENSION b1 & c1 APPLIED TO BASE METAL ONLY.
- ♠ DATUM A & B TO BE DETERMINED AT DATUM PLANE H.
- 9.- OUTLINE CONFORMS TO JEDEC OUTLINE TO-252AA.

Name
B
A 2.18 2.39 .086 .094 A1 - 0.13005 b 0.64 0.89 .025 .035 b1 0.65 0.79 .025 .031 7 b2 0.76 1.14 .030 .045 b3 4.95 5.46 .195 .215 4 c 0.46 0.61 .018 .024 c1 0.41 0.56 .016 .022 7 c2 0.46 0.89 .018 .035 D 5.97 6.22 .235 .245 6
A1 - 0.13 - .005 b 0.64 0.89 .025 .035 b1 0.65 0.79 .025 .031 7 b2 0.76 1.14 .030 .045 b3 4.95 5.46 .195 .215 4 c 0.46 0.61 .018 .024 c1 0.41 0.56 .016 .022 7 c2 0.46 0.89 .018 .035 D 5.97 6.22 .235 .245 6
b 0.64 0.89 .025 .035 b1 0.65 0.79 .025 .031 7 b2 0.76 1.14 .030 .045 b3 4.95 5.46 .195 .215 4 c 0.46 0.61 .018 .024 c1 0.41 0.56 .016 .022 7 c2 0.46 0.89 .018 .035 D 5.97 6.22 .235 .245 6
b1 0.65 0.79 .025 .031 7 b2 0.76 1.14 .030 .045 b3 4.95 5.46 .195 .215 4 c 0.46 0.61 .018 .024 .024 .016 .022 7 c2 0.46 0.89 .018 .035 .035 .056 .056 .022 .235 .245 6
b2 0.76 1.14 .030 .045 b3 4.95 5.46 .195 .215 4 c 0.46 0.61 .018 .024 c1 0.41 0.56 .016 .022 7 c2 0.46 0.89 .018 .035 D 5.97 6.22 .235 .245 6
b3 4.95 5.46 .195 .215 4 c 0.46 0.61 .018 .024 c1 0.41 0.56 .016 .022 7 c2 0.46 0.89 .018 .035 D 5.97 6.22 .235 .245 6
c 0.46 0.61 .018 .024 c1 0.41 0.56 .016 .022 7 c2 0.46 0.89 .018 .035 D 5.97 6.22 .235 .245 6
c1 0.41 0.56 .016 .022 7 c2 0.46 0.89 .018 .035 D 5.97 6.22 .235 .245 6
c2 0.46 0.89 .018 .035 D 5.97 6.22 .235 .245 6
D 5.97 6.22 .235 .245 6
- · - · · - · -
D1 5.21 - 205 - 4
E 6.35 6.73 .250 .265 6
E1 4.32170 - 4
e 2.29 BSC .090 BSC
H 9.40 10.41 .370 .410
L 1.40 1.78 .055 .070
L1 2.74 BSC .108 REF.
L2 0.51 BSC .020 BSC
L3 0.89 1.27 .035 .050 4
L4 - 1.02040
L5 1.14 1.52 .045 .060 3
\ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \ \
ø1 0° 15° 0° 15°
ø2 25° 35° 25° 35°

LEAD ASSIGNMENTS

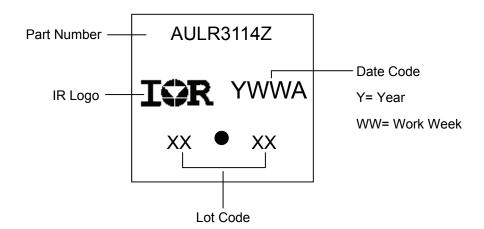
HEXFET

- 1.- GATE
- 2.- DRAIN 3.- SOURCE
- 4.- DRAIN

IGBT & CoPAK

- 1.- GATE
- 2.- COLLECTOR
- 3.- EMITTER
- 4. COLLECTOR

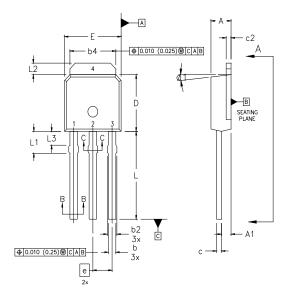
D-Pak (TO-252AA) Part Marking Information

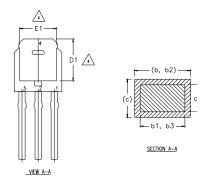


Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



I-Pak (TO-251AA) Package Outline (Dimensions are shown in millimeters (inches)





NOTES:

SYMBOL

- 1 DIMENSIONING AND TOLERANCING PER ASME Y14.5 M- 1994.
- 2 DIMENSIONS ARE SHOWN IN MILLIMETERS [INCHES].
- 3 DIMENSION D & E DO NOT INCLUDE MOLD FLASH, MOLD FLASH SHALL NOT EXCEED 0.005" (0.127) PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
- 4 THERMAL PAD CONTOUR OPTION WITHIN DIMENSION 64, L2, E1 & D1.

INCHES

- LEAD DIMENSION UNCONTROLLED IN L3.
- 6 DIMENSION 61, 63 APPLY TO BASE METAL ONLY.
 - OUTLINE CONFORMS TO JEDEC OUTLINE TO-251AA.

DIMENSIONS

8 CONTROLLING DIMENSION : INCHES.

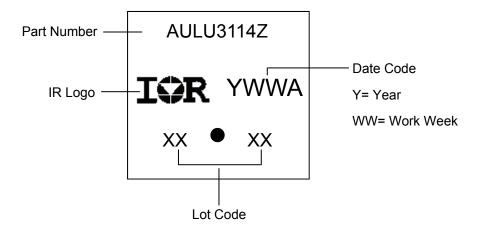
MILLIMETERS

LEAD ASSIGNMENTS

ı	н	F	X	F	F	т
		L	Λ		L	н

- 1.- GATE
- 2.- DRAIN 3 - SOURC
- 3.- SOURCE 4.- DRAIN
- MIN. NOTES 2.18 2.39 0.086 .094 A1 0.89 1.14 0.035 0.045 b 0.64 0.89 0.025 0.035 ь1 0.64 0.79 0.025 0.031 b2 0.76 1.14 0.030 0.045 0.76 1.04 0.030 0.041 5.00 5.46 0.195 0.215 b4 0.46 0.61 0.018 0.024 0.016 0.41 0.56 0.022 c1 c2 .046 0.86 0.018 0.035 D 5.97 6.22 0.235 0.245 D1 5.21 0.205 6.35 6.73 0.250 0.265 Ε1 4.32 0.170 0.090 BSC е L 8.89 9.60 0.350 0.380 L1 1,91 2.29 0.075 0.090 L2 0.89 1.27 0.035 0.050 L3 1.14 1.52 0.045 0.060 15*

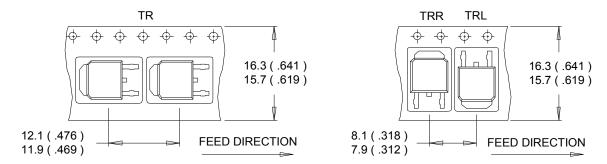
I-Pak (TO-251AA) Part Marking Information



Note: For the most current drawing please refer to IR website at http://www.irf.com/package/

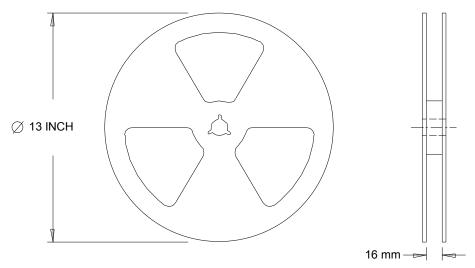


D-Pak (TO-252AA) Tape & Reel Information (Dimensions are shown in millimeters (inches))



NOTES:

- 1. CONTROLLING DIMENSION: MILLIMETER.
- 2. ALL DIMENSIONS ARE SHOWN IN MILLIMETERS (INCHES).
- 3. OUTLINE CONFORMS TO EIA-481 & EIA-541.



NOTES:

1. OUTLINE CONFORMS TO EIA-481.

Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



Qualification Information

		Automotive (per AEC-Q101)				
Qualification Level		Comments: This part number(s) passed Automotive qualification. Infineon's Industrial and Consumer qualification level is granted by extension of the higher Automotive level.				
Moioturo	Sanaitivity Laval	D-Pak	MSL1			
woisture	Moisture Sensitivity Level		IVISL I			
	Machine Madel	Class M4 (+/- 425V) [†]				
Machine Model			AEC-Q101-002			
ESD Human Body Model			Class H1C (+/- 2000V) [†]			
		AEC-Q101-001				
	Observed Davis Madal	Class C5 (+/- 1125V) [†]				
	Charged Device Model	AEC-Q101-005				
RoHS Cor	S Compliant Yes		Yes			

[†] Highest passing voltage.

Revision History

Date	Comments
10/29/2015	Updated datasheet with corporate template
10/29/2013	Corrected ordering table on page 1.

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